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Rapid bacterial identification based on surface-enhanced Raman scattering and machine learning (Conference Presentation) (Withdrawal Notice)

Chi-Sing Ho, Neal Jean, Amr Saleh, Stefano Ermon, Niaz Banaei, et al.

Chi-Sing Ho, Neal Jean, Amr Saleh, Stefano Ermon, Niaz Banaei, Jennifer A. Dionne, "Rapid bacterial identification based on surface-enhanced Raman scattering and machine learning (Conference Presentation) (Withdrawal Notice)," Proc. SPIE 10479, Light-Based Diagnosis and Treatment of Infectious Diseases, 1047904 (10 April 2018); doi: 10.1117/12.2291601

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[Chi-Sing Ho](#) [Neal Jean](#), [Amr Saleh](#) [Stefano Ermon](#), [Niaz Banaei](#) [Jennifer A Dionne](#), *Stanford Univ. (United States)*

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